- Operates With Single 5-V Power Supply
- LinBiCMOS™ Process Technology
- Two Drivers and Two Receivers
- ±30-V Input Levels
- Low Supply Current . . . 8 mA Typ
- Meets or Exceeds ANSI EIA/TIA-232-E and ITU Recommendation V.28
- Designed to be Interchangeable With Maxim MAX232
- Applications
 EIA/TIA-232-E
 Battery-Powered Systems
 Terminals
 Modems
 Computers
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015

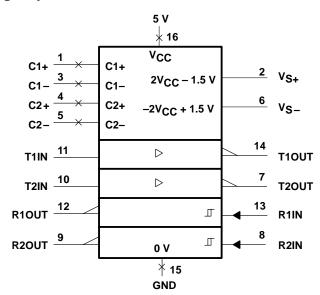
description

The MAX232 is a dual driver/receiver that includes a capacitive voltage generator to supply EIA/TIA-232-E voltage levels from a single 5-V supply. Each receiver converts EIA/TIA-232-E inputs to 5-V TTL/CMOS levels. These receivers have a typical threshold of 1.3 V and a typical hysteresis of 0.5 V, and can accept ±30-V inputs. Each driver converts TTL/CMOS input levels into EIA/TIA-232-E levels. The driver, receiver, and voltage-generator functions are available as cells in the Texas Instruments LinASIC™ library.

The MAX232 is characterized for operation from 0° C to 70° C. The MAX232I is characterized for operation from -40° C to 85° C.

D, DW, OR N PACKAGE (TOP VIEW) 16**∏** V_{CC} 15 GND V_{S+} [] 2 C1− ¶ 3 14 T10UT C2+ [4 13 **∏** R1IN C2− ¶ 5 12 R10UT 11 T1IN V_{S-} ∏ 6 T20UT 🛮 7 10**∏** T2IN R2IN ∏ 9 R20UT

logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Input supply voltage range, V _{CC} (see Note 1)	$\dots \dots -0.3 \text{ V to 6 V}$
Positive output supply voltage range, V _{S+}	$V_{CC} = 0.3 \text{ V to } 15 \text{ V}$
Negative output supply voltage range, V _S	0.3 V to -15 V
Input voltage range, V _I : Driver	\dots -0.3 V to V _{CC} + 0.3 V
Receiver	±30 V
Output voltage range, VO: T1OUT, T2OUT	V_{S-} -0.3 V to V_{S+} + 0.3 V
R10UT, R20UT	\dots -0.3 V to V _{CC} + 0.3 V
Short-circuit duration: T1OUT, T2OUT	unlimited
Operating free-air temperature range, T _A : MAX232	0°C to 70°C
MAX232I	–40°C to 85°C
Storage temperature range, T _{stq}	65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

	MIN	NOM	MAX	UNIT
Supply voltage, V _{CC}	4.5	5	5.5	V
High-level input voltage, VIH (T1IN,T2IN)	2			V
Low-level input voltage, V _{IL} (T1IN, T2IN)			0.8	V
Receiver input voltage, R1IN, R2IN			±30	V
Operating free-air temperature,T _A	0		70	°C

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP†	MAX	UNIT		
Va	High lovel output valtage	T1OUT, T2OUT	$R_L = 3 \text{ k}\Omega \text{ to GND}$)	5	7		V	
VOH High-level output voltage		R1OUT, R2OUT	$I_{OH} = -1 \text{ mA}$		3.5			v	
V	Low level output voltaget	T1OUT, T2OUT	$R_L = 3 \text{ k}\Omega \text{ to GND}$			-7	-5	V	
VOL	V _{OL} Low-level output voltage‡ R10UT, R20U		I _{OL} = 3.2 mA				0.4	V	
V _{IT+}	Receiver positive-going input threshold voltage	R1IN, R2IN	V _{CC} = 5 V,	T _A = 25°C		1.7	2.4	V	
V _{IT} –	Receiver negative-going input threshold voltage	R1IN, R2IN	V _{CC} = 5 V,	T _A = 25°C	0.8	1.2		V	
V _{hys}	Input hysteresis voltage	R1IN, R2IN	V _{CC} = 5 V		0.2	0.5	1	V	
rį	Receiver input resistance	R1IN, R2IN	V _{CC} = 5,	T _A = 25°C	3	5	7	kΩ	
r _o	Output resistance	T1OUT, T2OUT	$V_{S+} = V_{S-} = 0,$	V _O = ± 2 V	300			Ω	
los§	Short-circuit output current	T1OUT, T2OUT	V _{CC} = 5.5 V,	VO = 0		±10		mA	
lıs	Short-circuit input current	T1IN, T2IN	V _I = 0				200	μΑ	
ICC	Supply current		V _{CC} = 5.5 V, T _A = 25°C	All outputs open,		8	10	mA	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[§] Not more than one output should be shorted at a time.



NOTE 1: All voltage values are with respect to network ground terminal.

[‡] The algebraic convention, in which the least positive (most negative) value is designated minimum, is used in this data sheet for logic voltage levels only.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
tPLH(R)	Receiver propagation delay time, low- to high-level output	See Figure 2	500		ns
tPHL(R)	Receiver propagation delay time, high- to low-level output	See Figure 2	500		ns
SR	Driver slew rate	R_L = 3 kΩ to 7 kΩ, See Figure 3		30	V/µs
SR(tr)	Driver transition region slew rate	See Figure 4	3	·	V/µs

APPLICATION INFORMATION

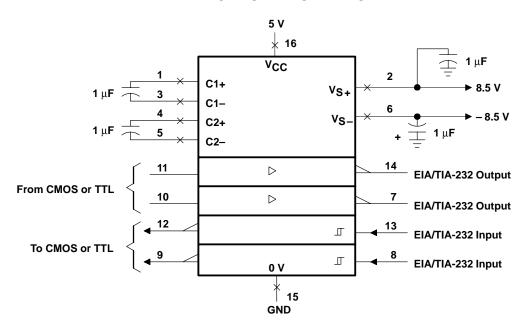
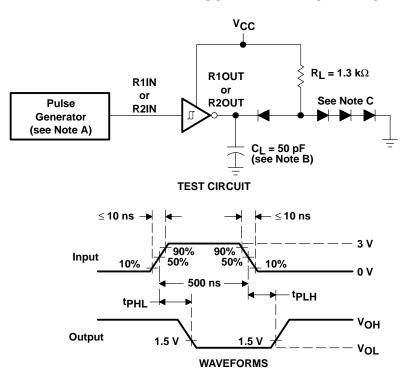


Figure 1. Typical Operating Circuit

PARAMETER MEASUREMENT INFORMATION

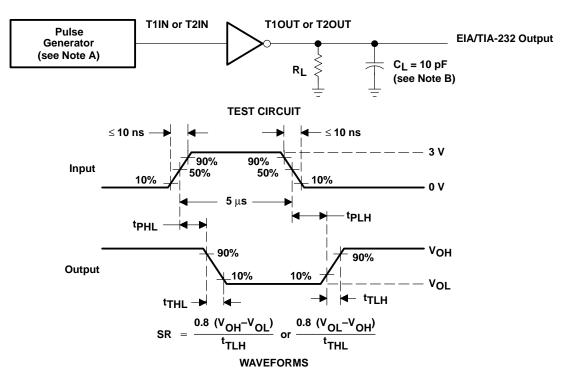


NOTES: A. The pulse generator has the following characteristics: $Z_0 = 50 \Omega$, duty cycle $\leq 50\%$.

- B. C_L includes probe and jig capacitance.
- C. All diodes are 1N3064 or equivalent.

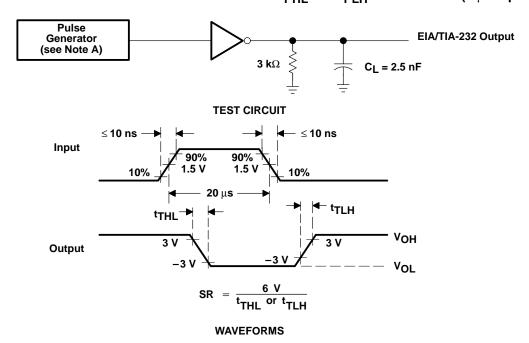
Figure 2. Receiver Test Circuit and Waveforms for tpHL and tpLH Measurement

PARAMETER MEASUREMENT INFORMATION



- NOTES: A. The pulse generator has the following characteristics: $Z_0 = 50 \Omega$, duty cycle $\leq 50\%$.
 - B. C_L includes probe and jig capacitance.

Figure 3. Driver Test Circuit and Waveforms for $t_{\mbox{\footnotesize{PHL}}}$ and $t_{\mbox{\footnotesize{PLH}}}$ Measurement (5-\$\mu{s}\$ input)



NOTE A: The pulse generator has the following characteristics: Z_O = 50 Ω , duty cycle \leq 50%.

Figure 4. Test Circuit and Waveforms for t_{THL} and t_{TLH} Measurement (20-μs input)

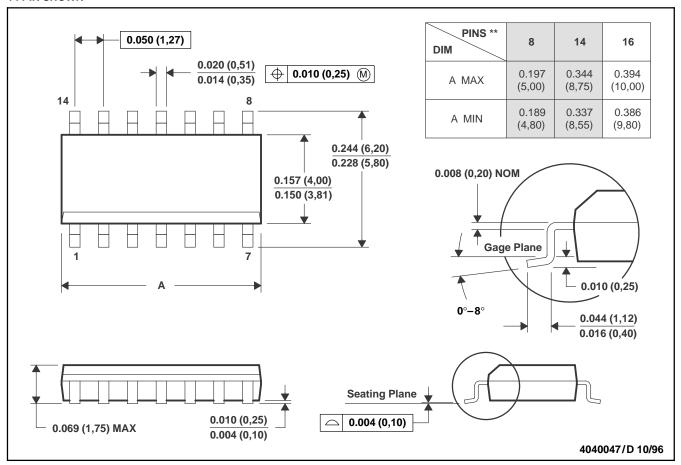
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MECHANICAL INFORMATION

D (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

14 PIN SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

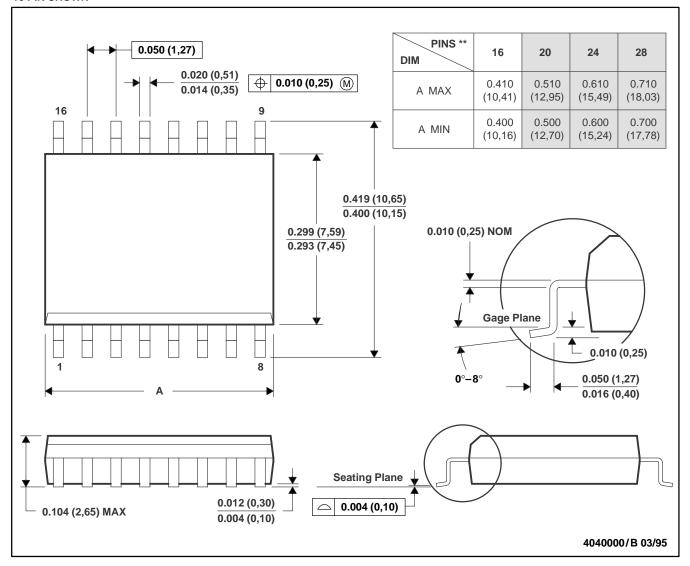
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012

MECHANICAL INFORMATION

DW (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

16 PIN SHOWN



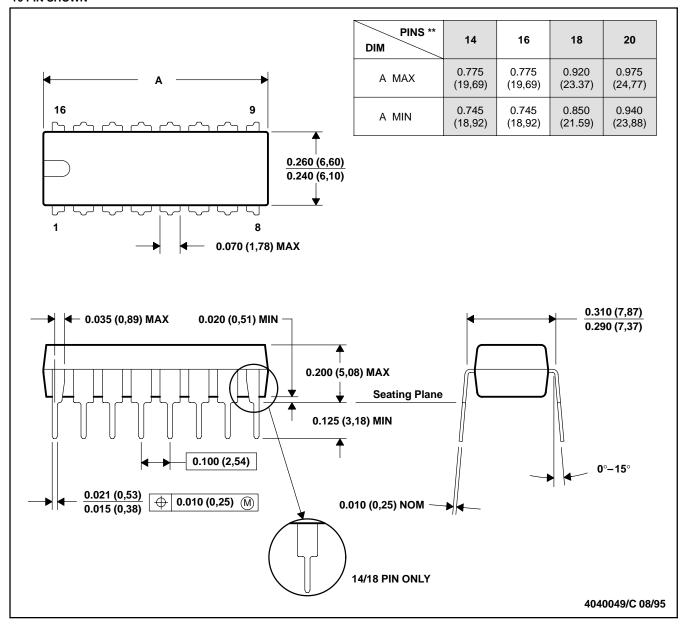
- NOTES: A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
 - D. Falls within JEDEC MS-013

MECHANICAL INFORMATION

N (R-PDIP-T**)

16 PIN SHOWN

PLASTIC DUAL-IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-001 (20 pin package is shorter then MS-001.)



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